



Developing High-Resolution Magnetic Microscopy Applications Using NV Centers in Diamond



Pauli Kehayias

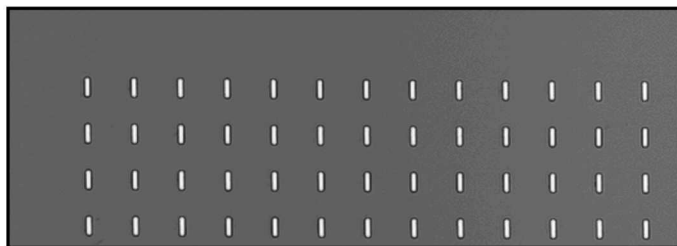
Sandia National Laboratories

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Magnetic imaging motivations

Micromagnet array



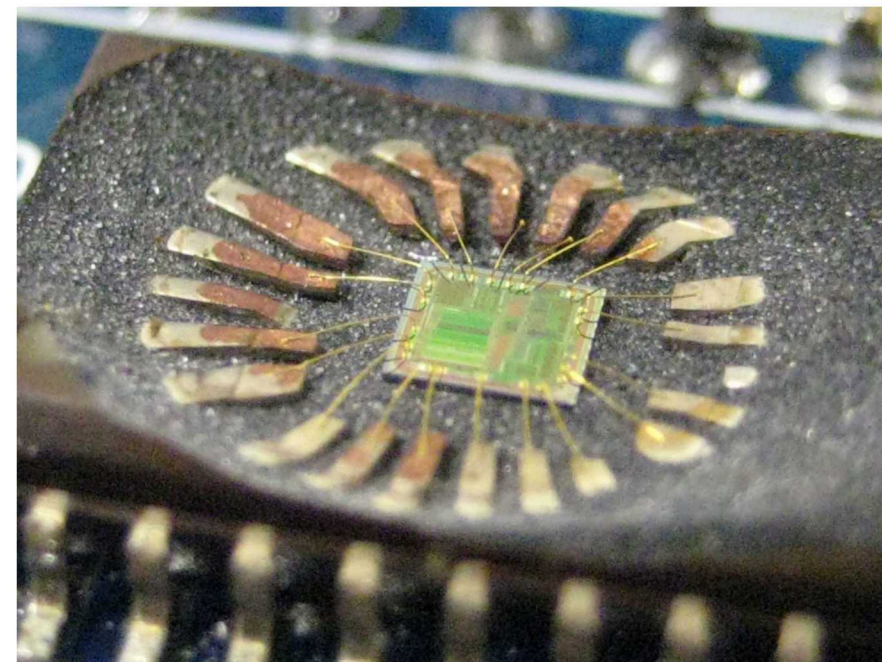
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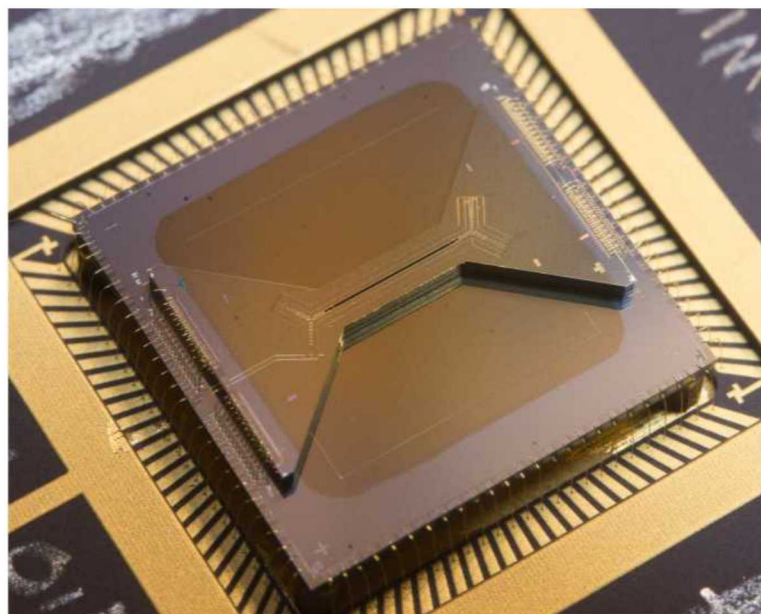
50 μm

100 x 100 array of nickel micromagnets ($1 \times 4 \mu\text{m}$) with 10 μm spacing

Detecting counterfeits and Trojans in electronics



Ion chip characterization for quantum computing



Magnetic microscopy wish list



As good as possible:

- Single-pixel sensitivity
- Spatial resolution
- Sample-sensor standoff distance

Also important to consider:

- Operating conditions (bias field, temperature, ...)
- Field of view
- Frequency range
- $|\vec{B}|$, $\vec{B} \cdot \hat{n}$, or \vec{B} measurements
- Raster-scanning or parallel readout

Magnetic microscopy wish list

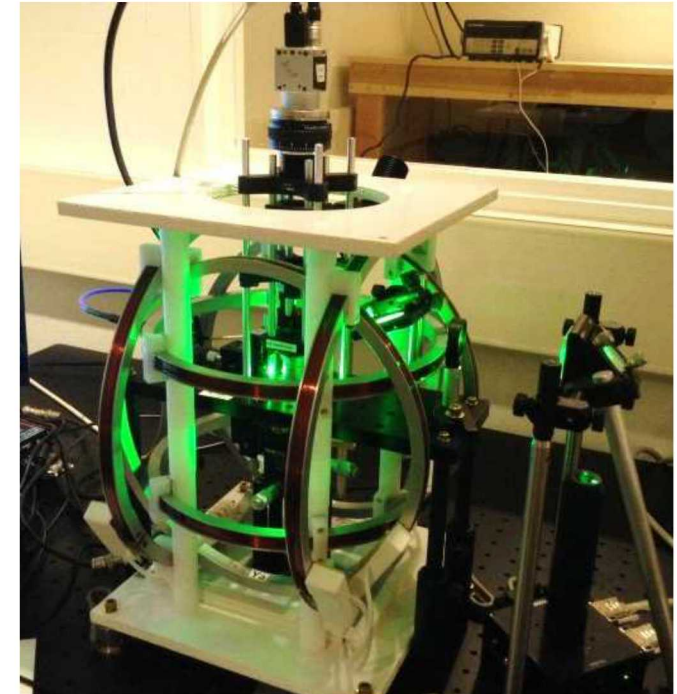
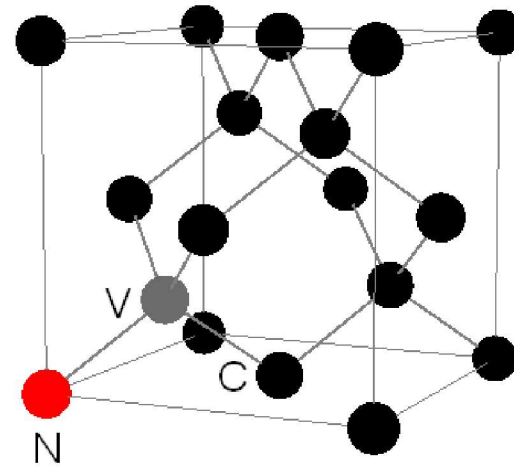
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Our approach:
Widefield magnetic
microscopy using NV centers
in diamond

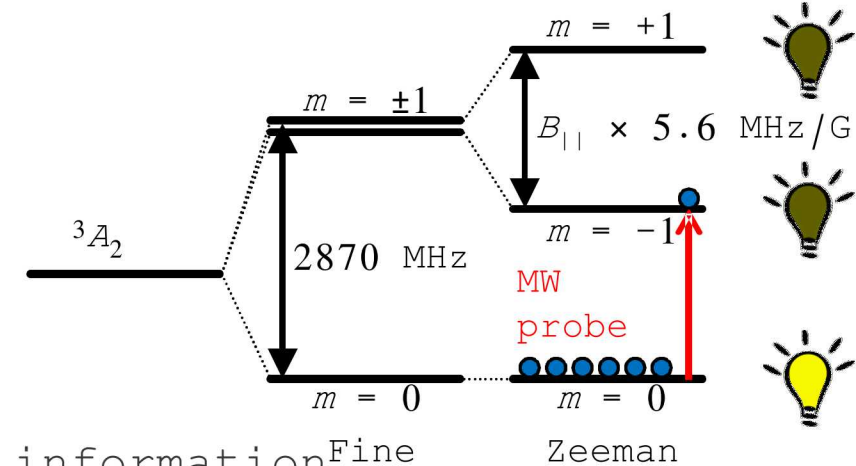
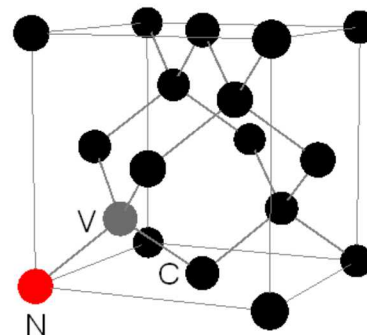


NV diamond overview

Naturally-occurring paramagnetic color

Discrete electronic states

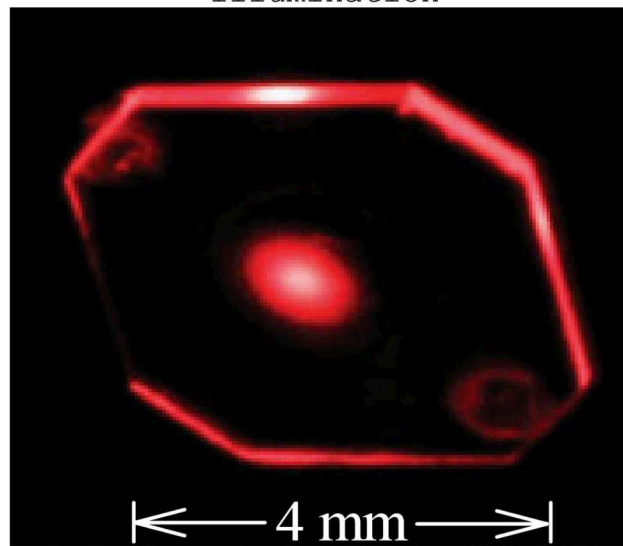
- Magnetically-sensitive ground state
- Optical initialization & readout
- Sublevel-dependent fluorescence
- DC to GHz magnetometry for vector or scalar projection information



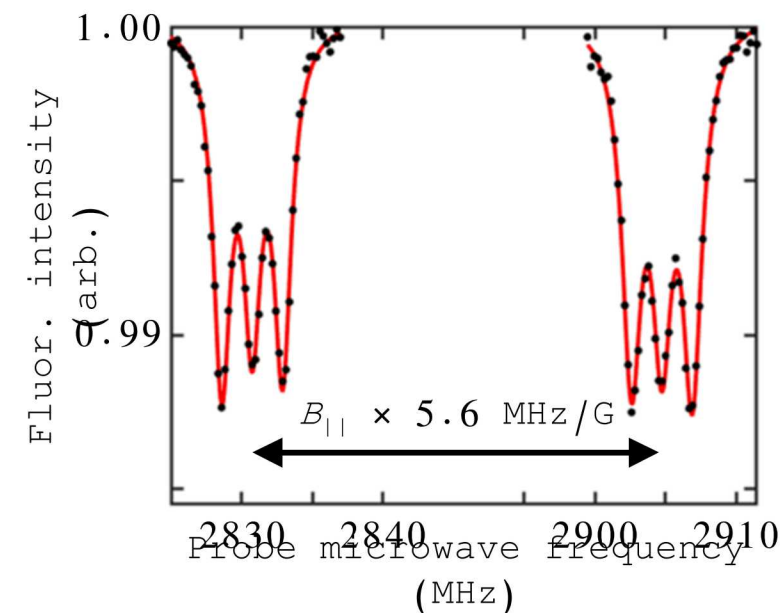
Synthetic diamond chips
(few mm)



NV fluorescence under laser
illumination



D. Le Sage et al., PRB 85 121202(R)
(2012)



NVs are good for high-res magnetic imaging

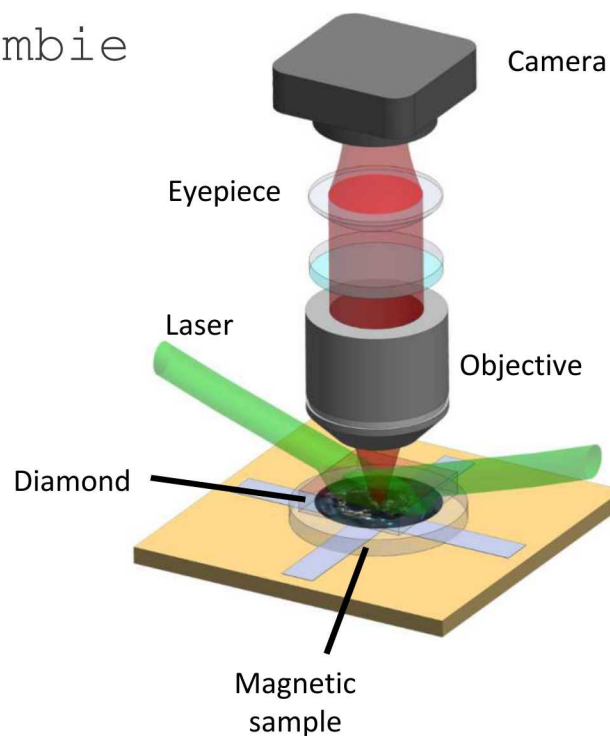
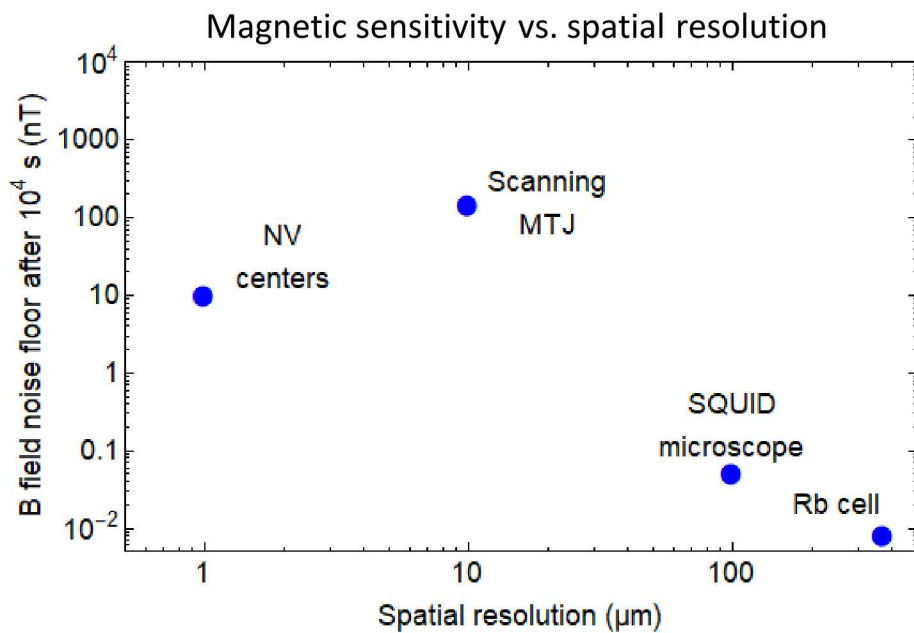
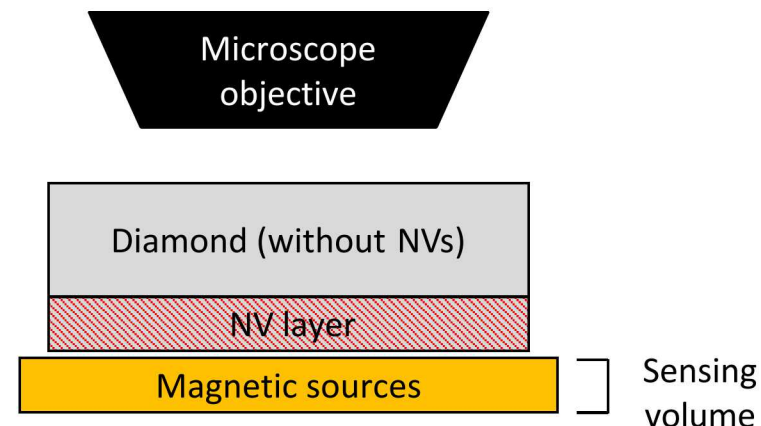
Small sensor-target separation

High magnetic moment sensitivity

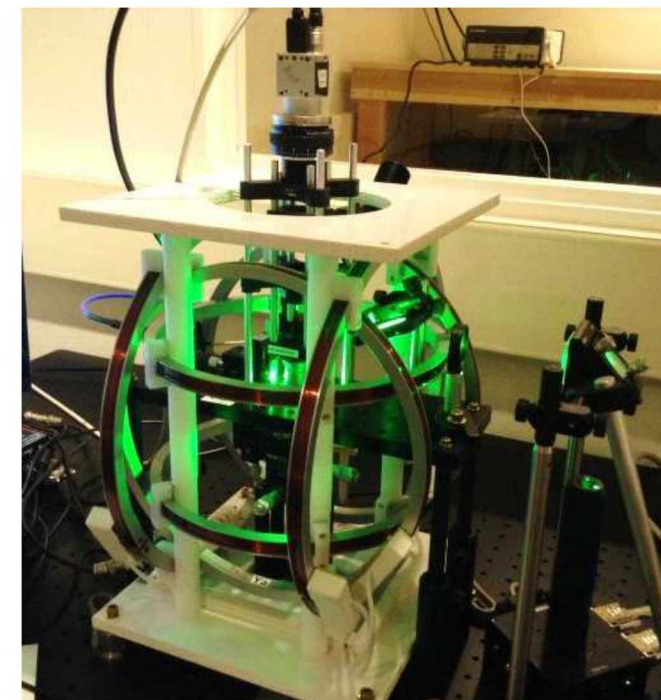
Few-mm FOV, micron-scale spatial resolution

Overlay optical and magnetic images

No sensor scanning, works at ambie



D. R. Glenn et al.,
 Geochem. Geophys. Geosyst.
 18, 8 (2017)

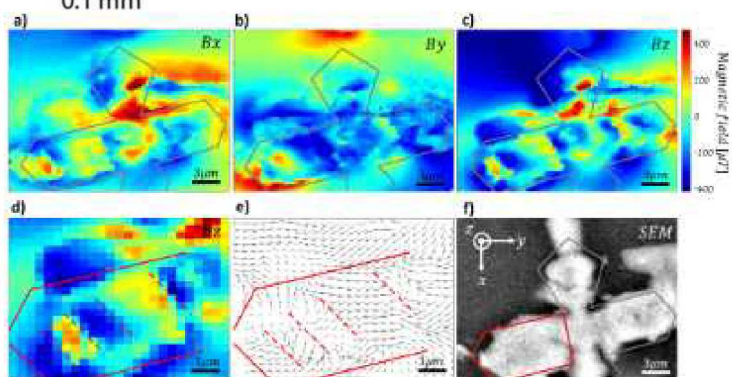
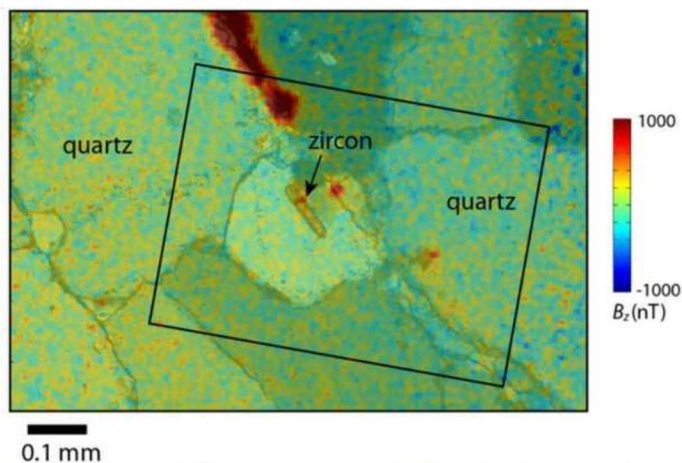


Widefield NV magnetic microscopy setup

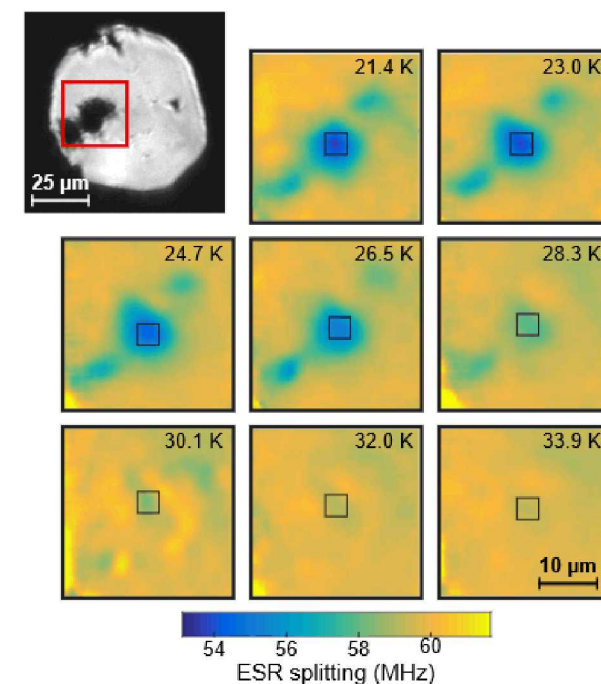
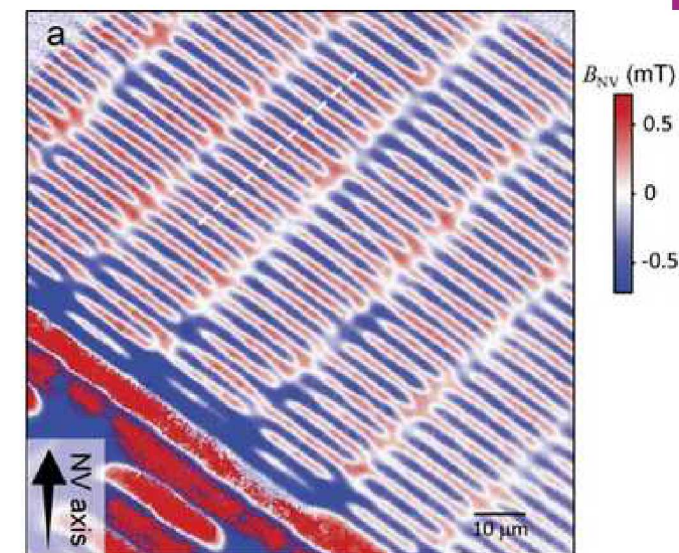
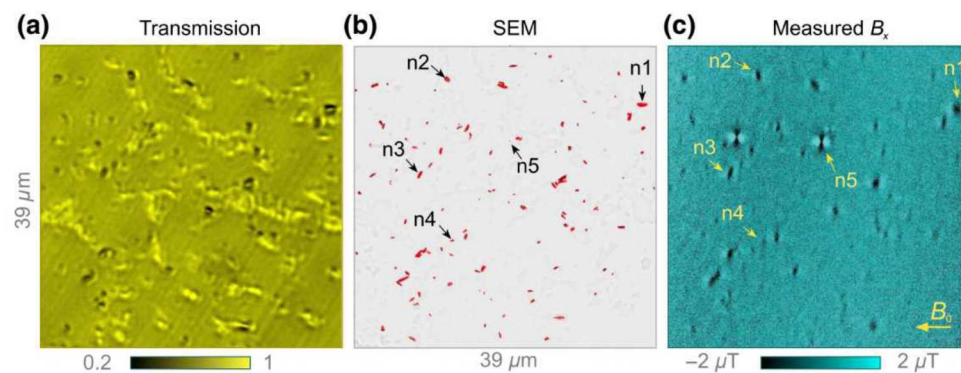
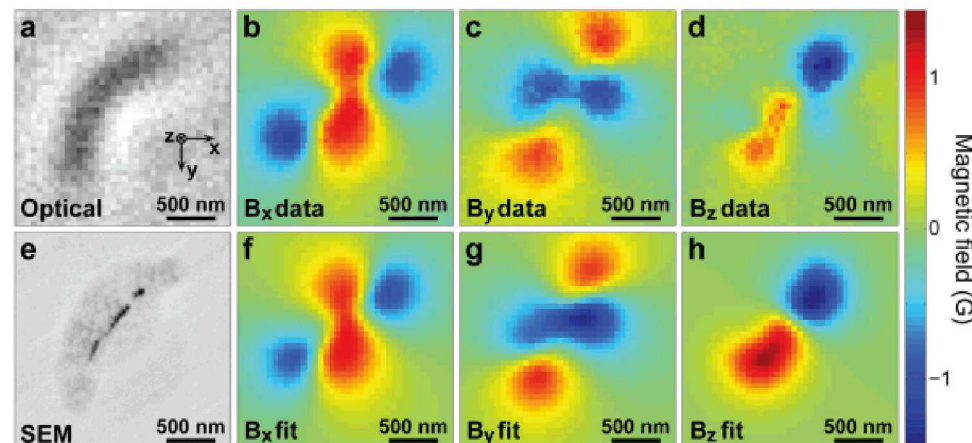
NV magnetic imaging highlights

Condensed-
matter
physics

Geomagnetism



Biomagnetism



- B. P. Weiss et al., *Geology* 46 5, 427-430 (2018)
 E. Farchi et al., *Spin* 07 03 1740015 (2017)
 D. Le Sage et al., *Nature* 496, 486-489 (2013)
 I. Fescenko et al., *Phys. Rev. Applied* 11 034029 (2019)
 D. A. Simpson et al., *Sci. Rep.* 6 22797 (2016)
 M. Lesik et al., *Science* 366 6471 (2019)

Application #1: micromagnet array PUFs

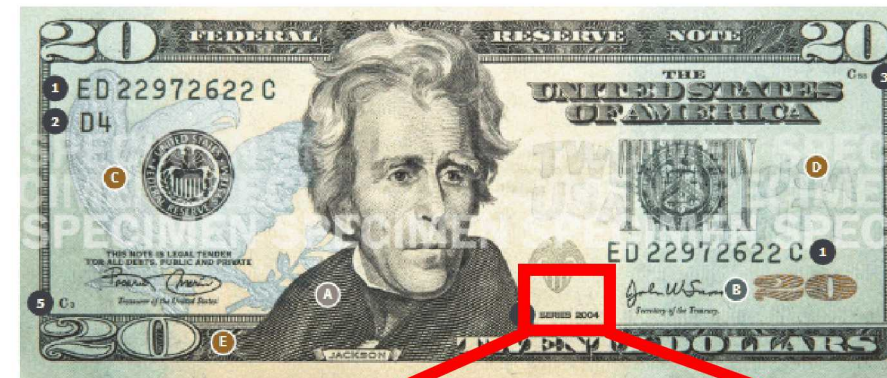
To protect against counterfeiters, tag each object with a unique fingerprint

Requirements for PUFs:

- Easy to make, hard to reproduce individual ones
- Random and unique (difficult to predict)
- Efficient to characterize, reproducible output
- Low-cost, resilient

Examples:

- Fibers in paper
- Manufacturing variations in electronics
- Our work: fabricated micromagnets

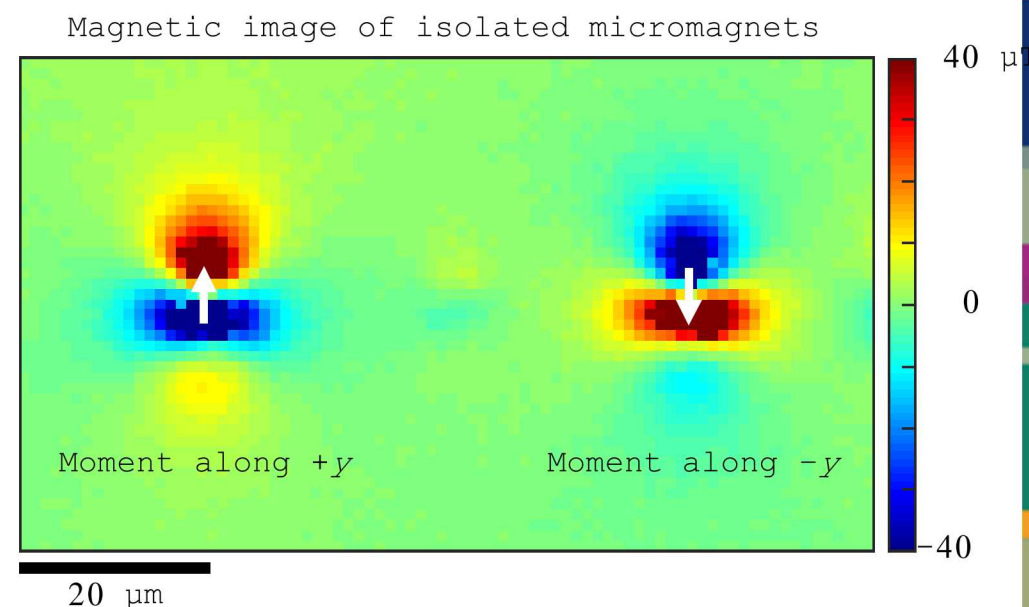
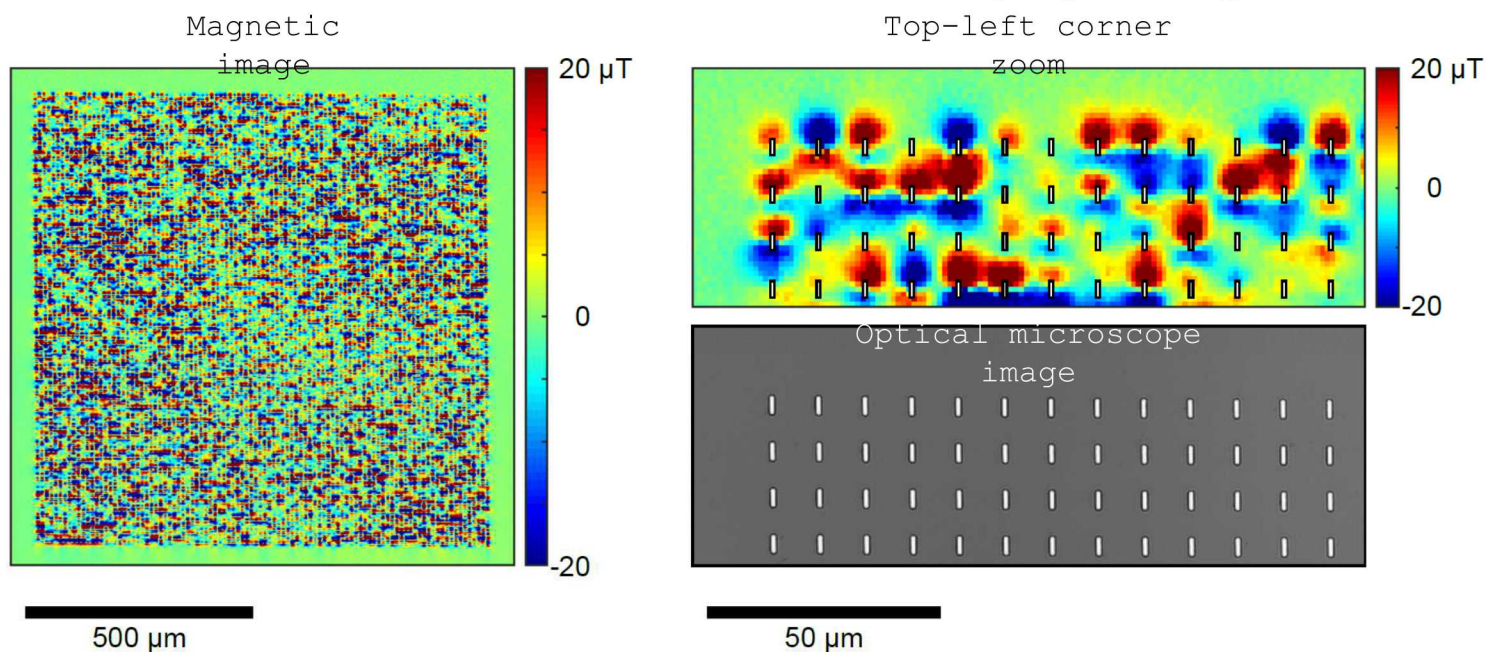
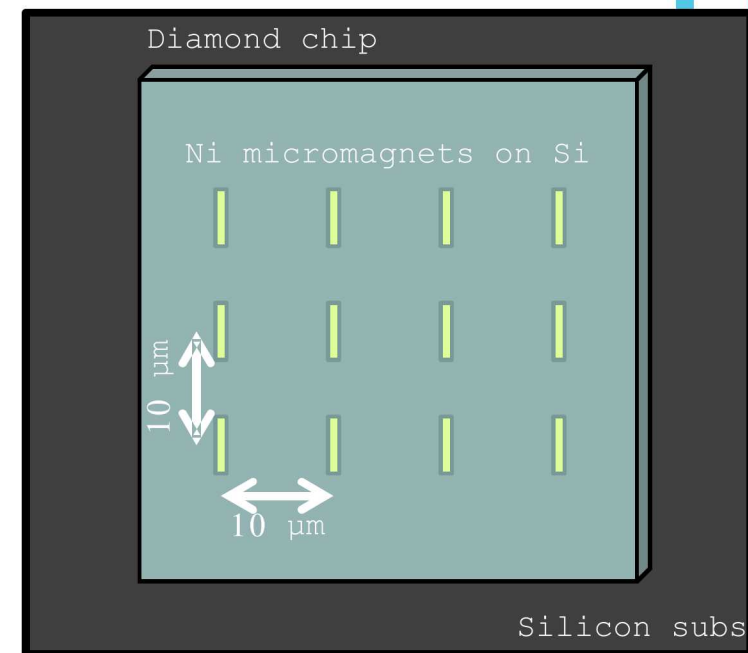


Anti-counterfeiting fibers in a banknote

Application #1: micromagnet array PUFs

Use a micromagnet array as a PUF

- Each magnet has a random (uncontrollable) magnetization
- Measure each micromagnet, generate a binary {0,1} for each
- Benefits: PUF is unpowered, compact, CMOS-compatible, stable over geological timescales, and can be hidden under a thin opaque layer



Application #2: counterfeit electronics probe

Passively interrogate IC behavior and find counterfeits & Trojans

Commercial 555 timer die

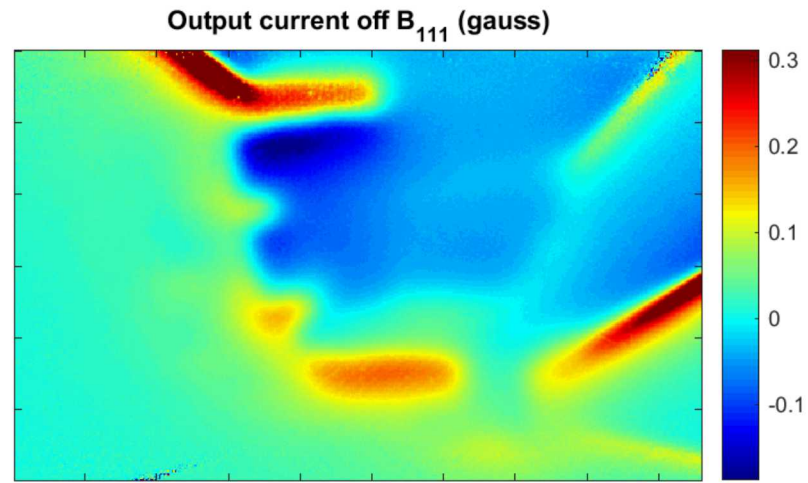
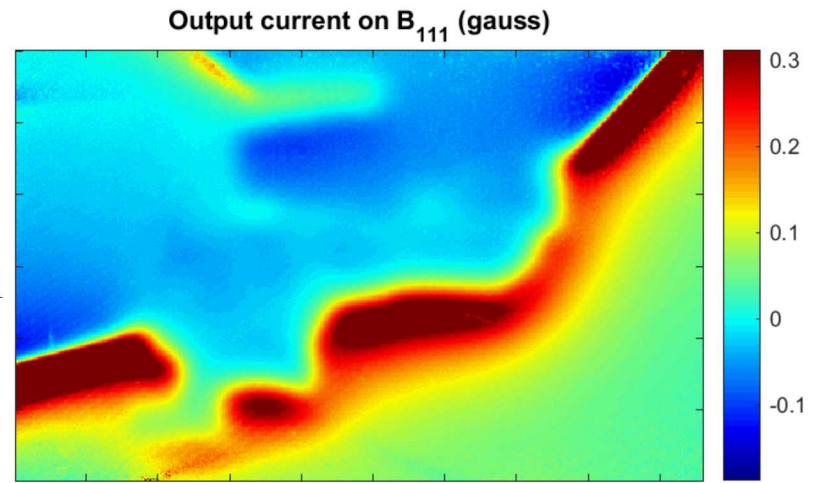
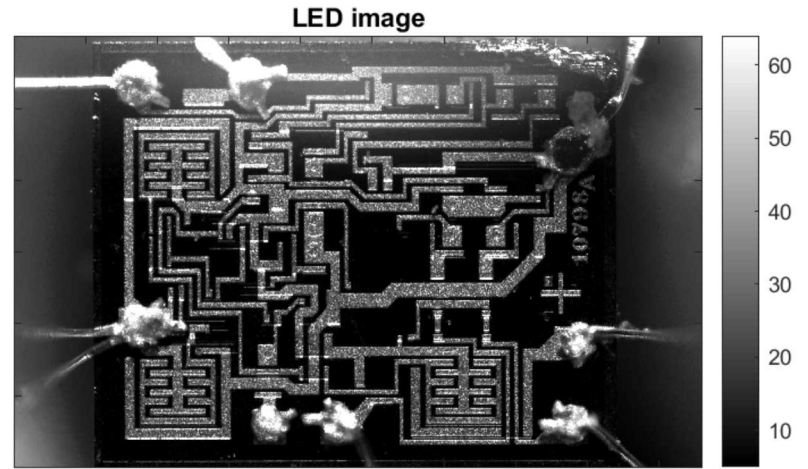
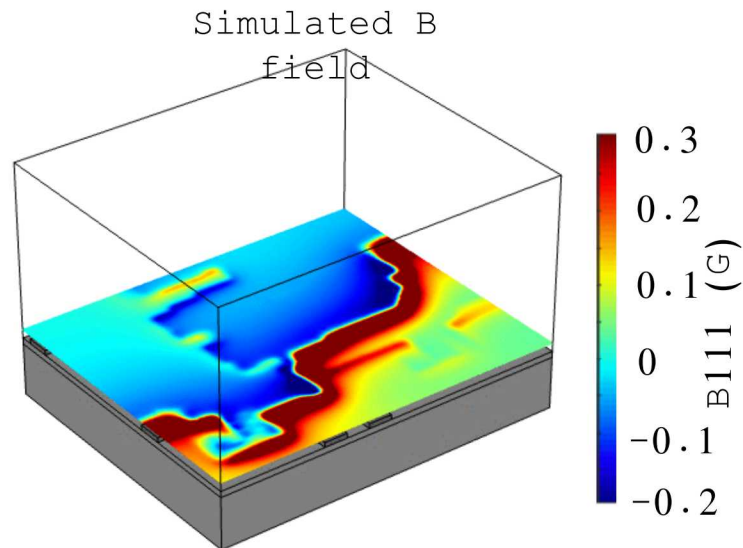


Image dimensions: 1.31 x 2.09 mm

Application #3: ion chip characterization

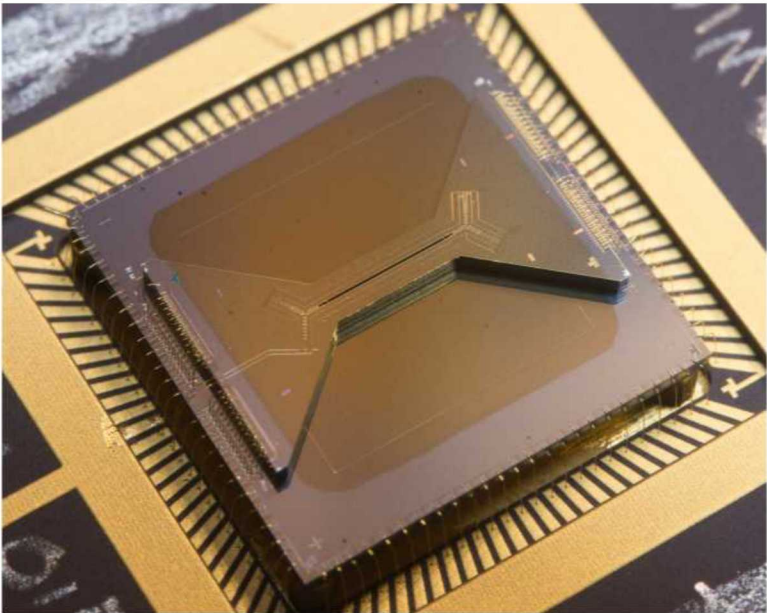
Characterize ion chips over a wide frequency range

- DC magnetic gradients
- RF trapping potential (10-100 MHz)
- Microwave chip traps (few GHz)

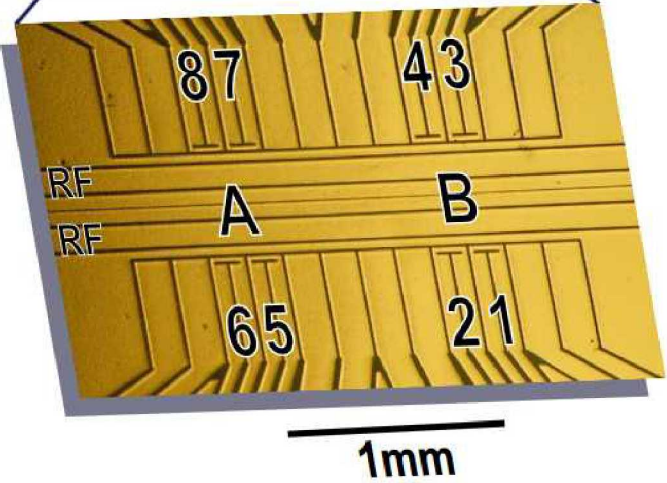
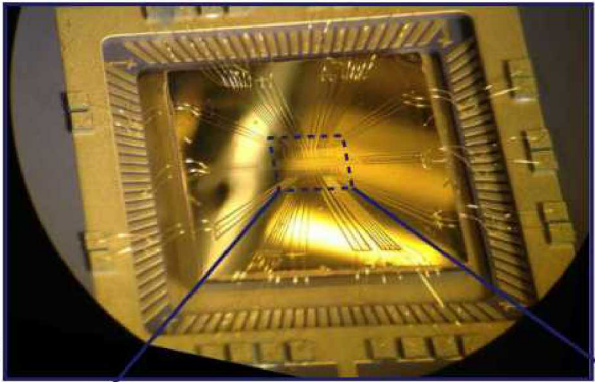
Ion chip with 3.2 GHz near-field microwave gates

Validate FEM calculation & manufacturing

Test an ion chip before installing it in the exper



Sandia high-optical-access ion chip



Summary

As good as possible:

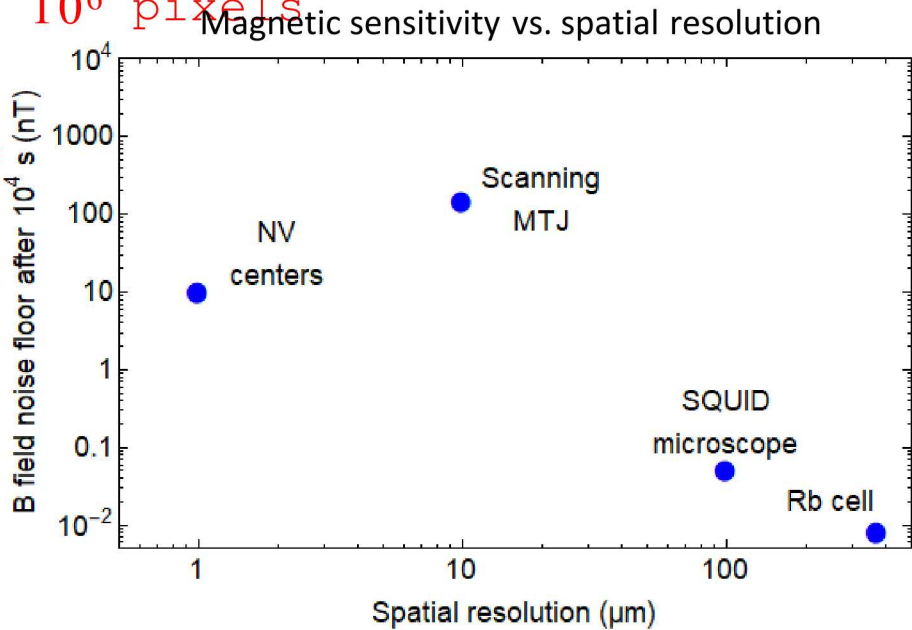
- Single-pixel sensitivity
- Spatial resolution
- Sample-sensor standoff distance

Few μT after 1 s in a 1 μm pixel
Few microns
As close as ~ 10 nm

Also important to consider:

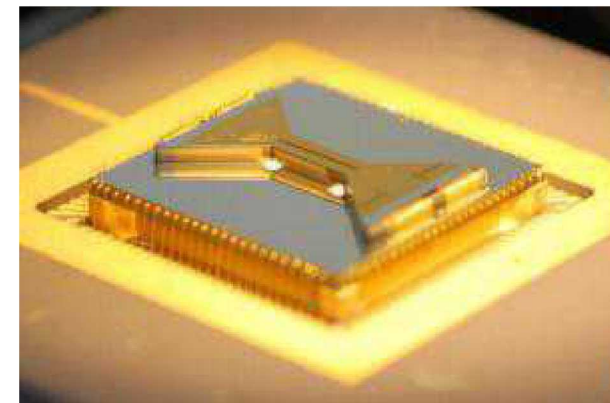
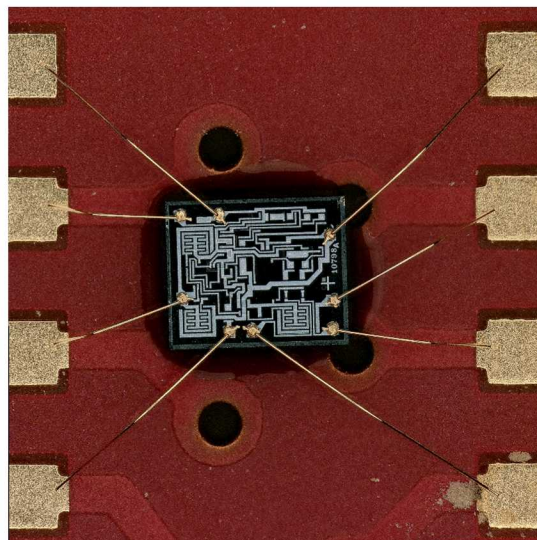
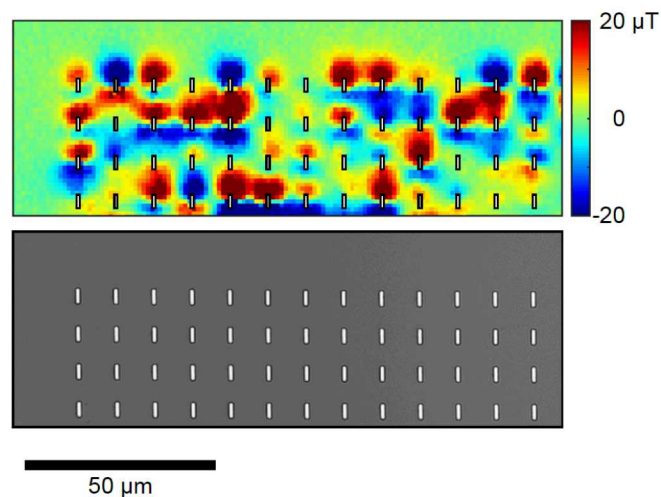
- Operating conditions
- Field of view
- Frequency range
- $|\vec{B}|$, $\vec{B} \cdot \hat{n}$, or \vec{B} measurements
- Raster-scanning or parallel readout

Ambient conditions, arbitrary B_0
 ~ 0.1 to few mm, 10^6 pixels
DC to 100 GHz
Vector or proje
Parallel





NV magnetic imaging enables new insights and directions for related fields



Ongoing investigations into alternative optically-active defects:

- SiV, SnV, PbV, ST1, ..., SiC polymorphs, ...

Collaborators:

- Micromagnet PUFs: Ezra Bussmann, Tzu-Ming Lu, Andy Mounce
- IC magnetic imaging: Ray Haltli, Edlyn Levine, Tzu-Ming Lu, Andy Mounce, Denise Tibbetts, Darlene Udoni
- Ion chip traps: Susan Clark, Ray Haltli, Melissa Revelle